2SC3506

Silicon NPN triple diffusion planar type

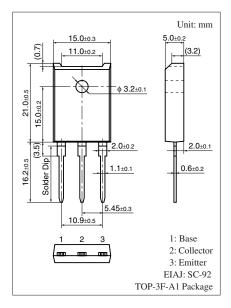
For high-speed switching

Features

- High-speed switching
- \bullet High collector-base voltage (Emitter open) V_{CBO}
- \bullet Satisfactory linearity of forward current transfer ratio h_{FE}
- Full-pack package which can be installed to the heat sink with one screw

Parameter		Symbol	Rating	Unit					
Collector-base voltage (Emitter open)		V _{CBO}	1 000	V					
Collector-emitter voltage (E-B short)		V _{CES}	1 000	V					
Collector-emitter voltage (V _{CEO}	800	V						
Emitter-base voltage (Collector open)		V _{EBO}	7	V					
Collector current		I _C	3	А					
Base current		IB	2	А					
Peak collector current		I _{CP}	6	А					
Collector power dissipation		P _C	70	W					
	$T_a = 25^{\circ}C$		3.0						
Junction temperature		Tj	150	°C					
Storage temperature		T _{stg}	-55 to +150	°C					

Absolute Maximum Ratings $T_C = 25^{\circ}C$

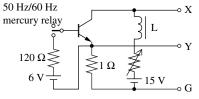


\blacksquare Electrical Characteristics $T_C = 25^{\circ}C \pm 3^{\circ}C$

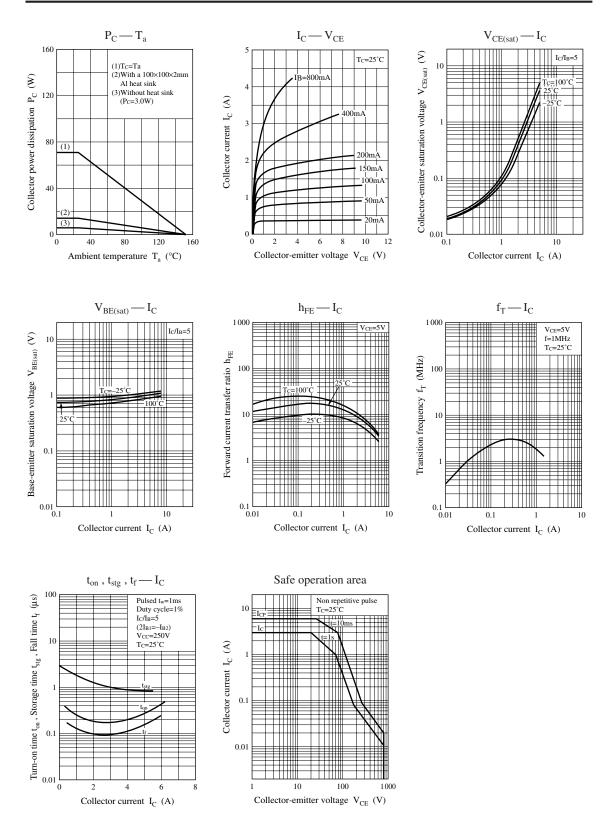
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector-emitter sustaining voltage *	V _{CEO(SUS)}	$I_C = 0.5 \text{ A}, L = 50 \text{ mH}$	800			V
Collector-base cutoff current (Emitter open)	I _{CBO}	$V_{CB} = 1000$ V, $I_E = 0$			50	μΑ
Emitter-base cutoff current (Collector open)	I _{EBO}	$V_{EB} = 7 V, I_C = 0$			50	μΑ
Forward current transfer ratio	h _{FE}	$V_{CE} = 5 V, I_C = 2 A$	6			
Collector-emitter saturation voltage	V _{CE(sat)}	$I_{\rm C} = 2 \text{ A}, I_{\rm B} = 0.4 \text{ A}$			1.5	V
Base-emitter saturation voltage	V _{BE(sat)}	$I_{\rm C} = 2 \text{ A}, I_{\rm B} = 0.4 \text{ A}$			1.5	V
Transition frequency	f _T	$V_{CE} = 5 V, I_C = 0.2 A, f = 1 MHz$		4		MHz
Turn-on time	t _{on}	$I_C = 2 A$			1	μs
Storage time	t _{stg}	$I_{B1} = 0.4 \text{ A}, I_{B2} = -0.8 \text{ A}$			2.5	μs
Fall time	t _f	$V_{CC} = 250 \text{ V}$			0.5	μs

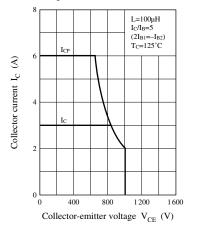
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

2. *: V_{CEO(SUS)} test circuit 50



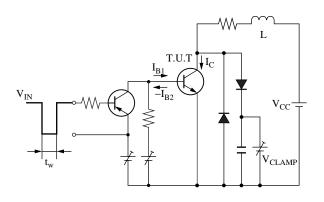
Panasonic

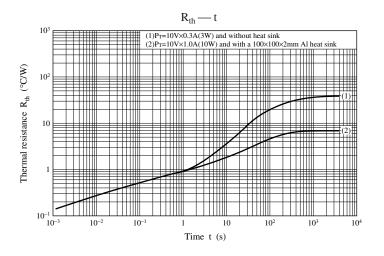




Safe operation area (Reverse bias)

Safe operation area (Reverse bias) measurement circuit





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